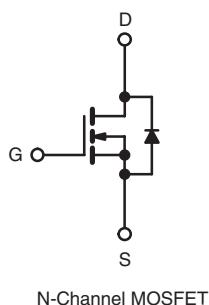
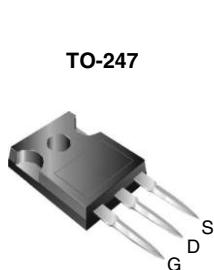


## Power MOSFET

PRODUCT SUMMARY	
$V_{DS}$ (V)	500
$R_{DS(on)}$ (Max.) ( $\Omega$ )	$V_{GS} = 10$ V      0.37
$Q_g$ (Max.) (nC)	77
$Q_{gs}$ (nC)	26
$Q_{gd}$ (nC)	34
Configuration	Single



### FEATURES

- Low Gate Charge  $Q_g$  Results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic  $dV/dt$  Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective  $C_{oss}$  Specified
- Lead (Pb)-free


**RoHS**  
COMPLIANT

### APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching

### TYPICAL SMPS TOPOLOGIES

- Two Transistor Forward
- Half Bridge and Full Bridge
- PFC Boost

### ORDERING INFORMATION

Package	TO-247
Lead (Pb)-free	IRFP450NPbF SiHFP450N-E3
SnPb	IRFP450N SiHFP450N

### ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	$V_{DS}$	500	V
Gate-Source Voltage	$V_{GS}$	$\pm 30$	
Continuous Drain Current	$I_D$	14	A
		8.8	
Pulsed Drain Current <sup>a</sup>	$I_{DM}$	56	W/°C
Linear Derating Factor		1.6	
Single Pulse Avalanche Energy <sup>b</sup>	$E_{AS}$	170	mJ
Repetitive Avalanche Current <sup>a</sup>	$I_{AR}$	14	A
Repetitive Avalanche Energy <sup>a</sup>	$E_{AR}$	20	mJ
Maximum Power Dissipation	$P_D$	200	W
Peak Diode Recovery $dV/dt$ <sup>c</sup>	$dV/dt$	5.0	V/ns
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature)		300 <sup>d</sup>	
Mounting Torque	6-32 or M3 screw	10	lbf · in
		1.1	N · m

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- Starting  $T_J = 25$  °C,  $L = 1.7$  mH,  $R_G = 25$  Ω,  $I_{AS} = 14$  A (see fig. 12).
- $I_{SD} \leq 14$  A,  $dl/dt \leq 510$  A/μs,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150$  °C.
- 1.6 mm from case.

# IRFP450N, SiHFP450N

Vishay Siliconix

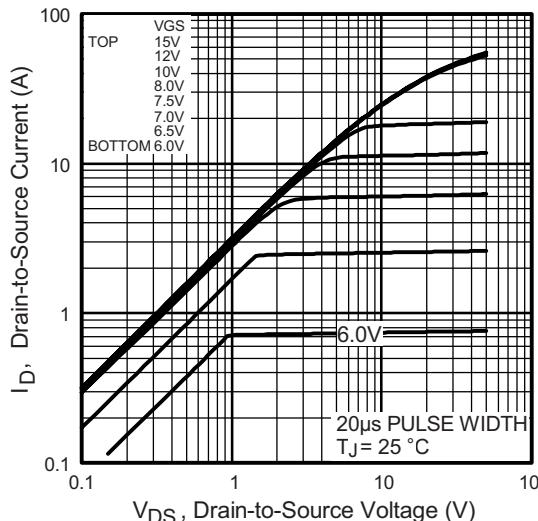
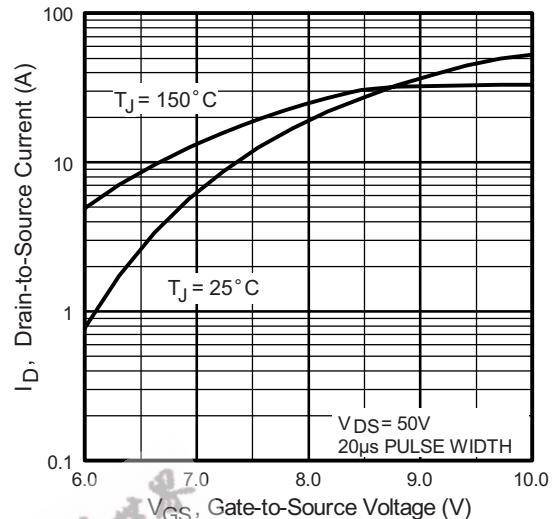
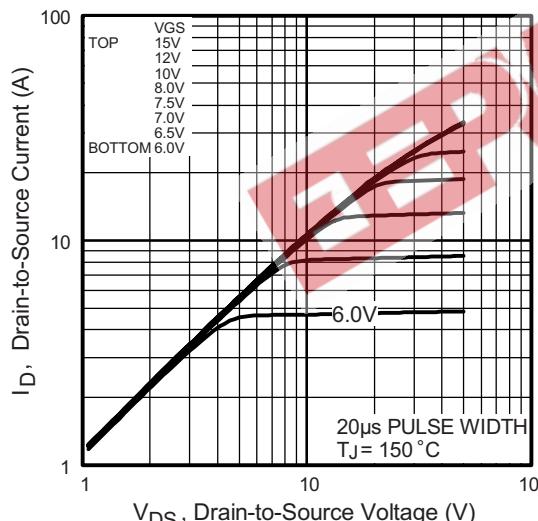
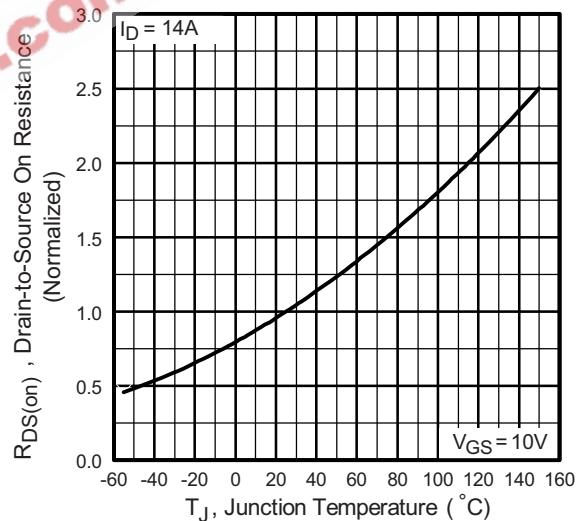


THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	°C/W
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.64	

SPECIFICATIONS T <sub>J</sub> = 25 °C, unless otherwise noted							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.59	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		3.0	-	5.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 30 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	-	25	μA
		V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V   I <sub>D</sub> = 8.4 A <sup>b</sup>		-	-	0.37	Ω
Forward Transconductance	g <sub>f</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 8.4 A		7.9	-	-	S
<b>Dynamic</b>							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5		-	2260	-	pF
Output Capacitance	C <sub>oss</sub>			-	210	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	14	-	
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 1.0 V, f = 1.0 MHz	-	2410	-	
			V <sub>DS</sub> = 400 V, f = 1.0 MHz	-	59	-	
			V <sub>DS</sub> = 0 V to 400 V <sup>c</sup>	-	110	-	
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 14 A, V <sub>DS</sub> = 400 V, see fig. 6 and 13 <sup>b</sup>	-	-	77	nC
Gate-Source Charge	Q <sub>gs</sub>			-	-	26	
Gate-Drain Charge	Q <sub>gd</sub>			-	-	34	
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 14 A R <sub>G</sub> = 6.2 Ω, V <sub>GS</sub> = 10 V, see fig. 10 <sup>b</sup>		-	20	-	ns
Rise Time	t <sub>r</sub>		-	63	-		
Turn-Off Delay Time	t <sub>d(off)</sub>		-	29	-		
Fall Time	t <sub>f</sub>		-	25	-		
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	14	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	56	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 14 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.4	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	430	650	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>		-	3.7	5.6	μC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )					

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width ≤ 400 μs; duty cycle ≤ 2 %.
- c. C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80 % V<sub>DS</sub>.

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

**Fig. 1 - Typical Output Characteristics**

**Fig. 3 - Typical Transfer Characteristics**

**Fig. 2 - Typical Output Characteristics**

**Fig. 4 - Normalized On-Resistance vs. Temperature**

# IRFP450N, SiHFP450N

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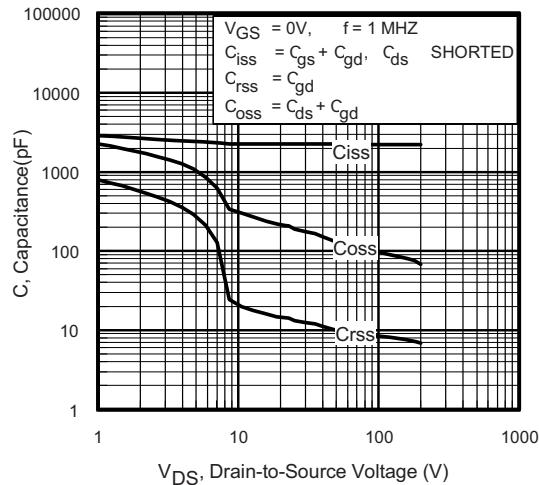


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

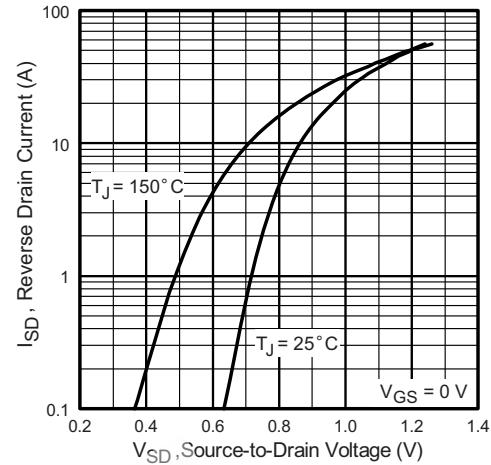


Fig. 7 - Typical Source-Drain Diode Forward Voltage

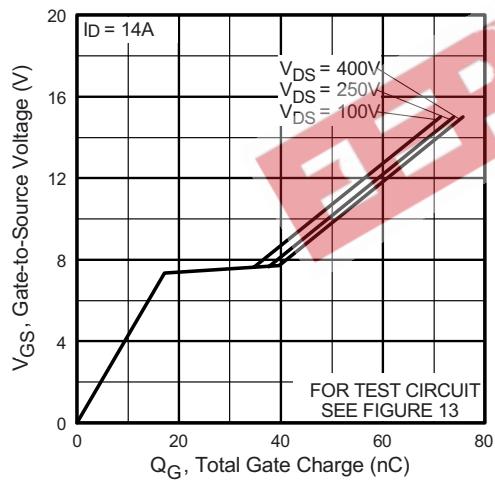


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

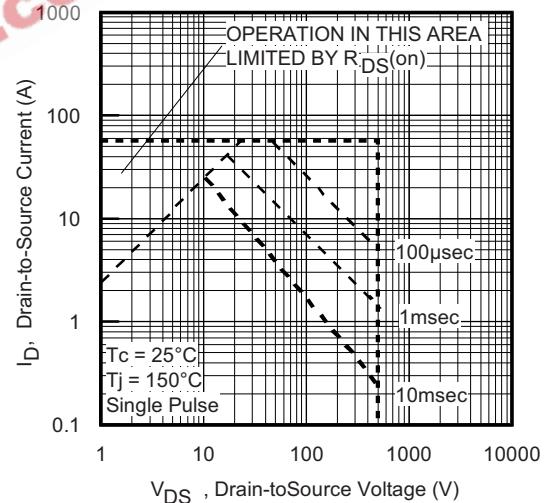


Fig. 8 - Maximum Safe Operating Area

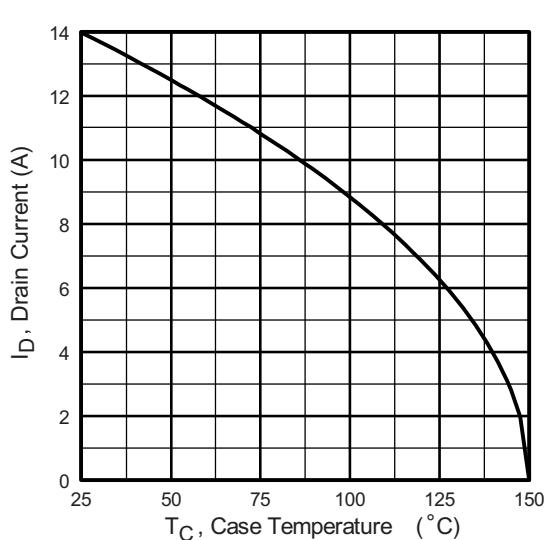


Fig. 9 - Maximum Drain Current vs. Case Temperature

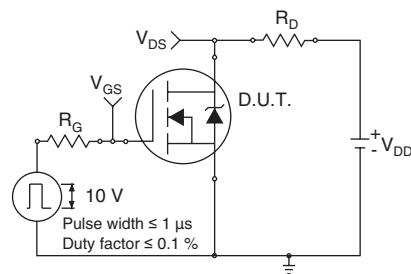


Fig. 10a - Switching Time Test Circuit

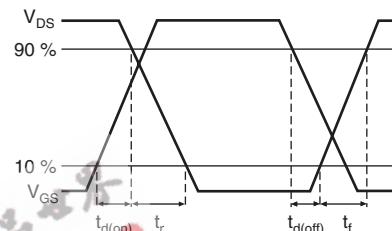


Fig. 10b - Switching Time Waveforms

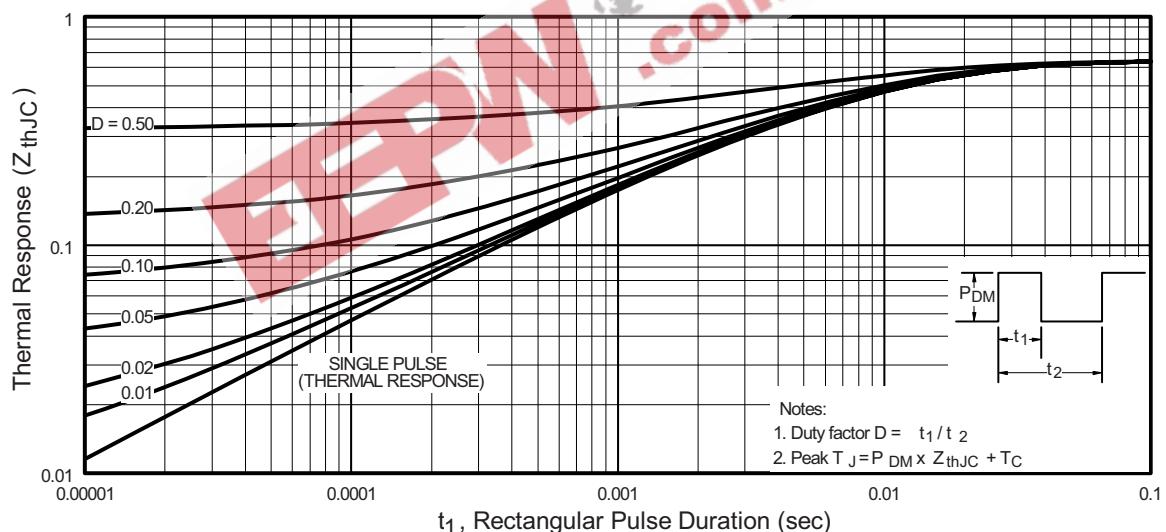


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRFP450N, SiHFP450N

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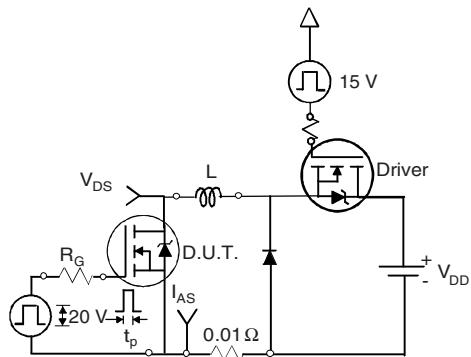


Fig. 12a - Unclamped Inductive Test Circuit

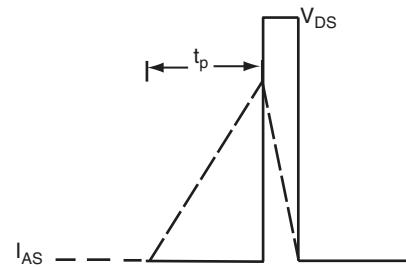


Fig. 12b - Unclamped Inductive Waveforms

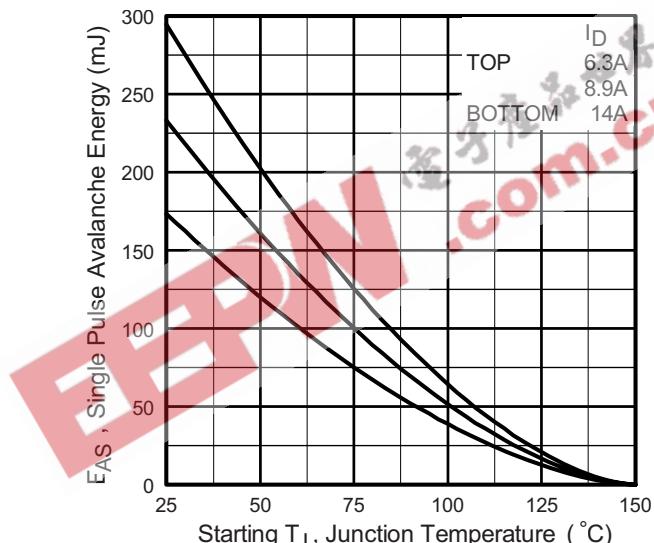


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

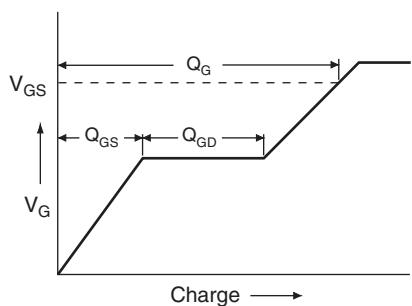


Fig. 13a - Basic Gate Charge Waveform

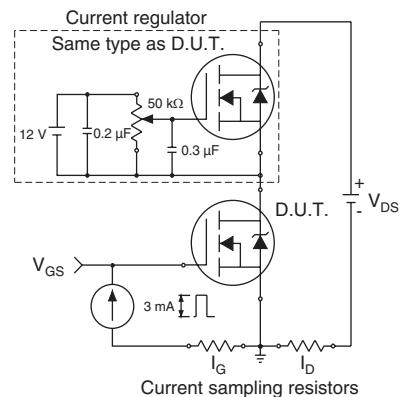
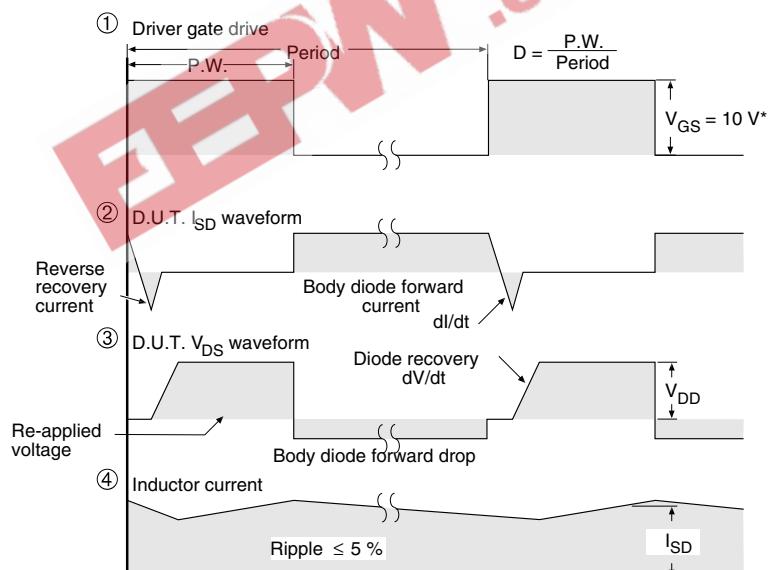
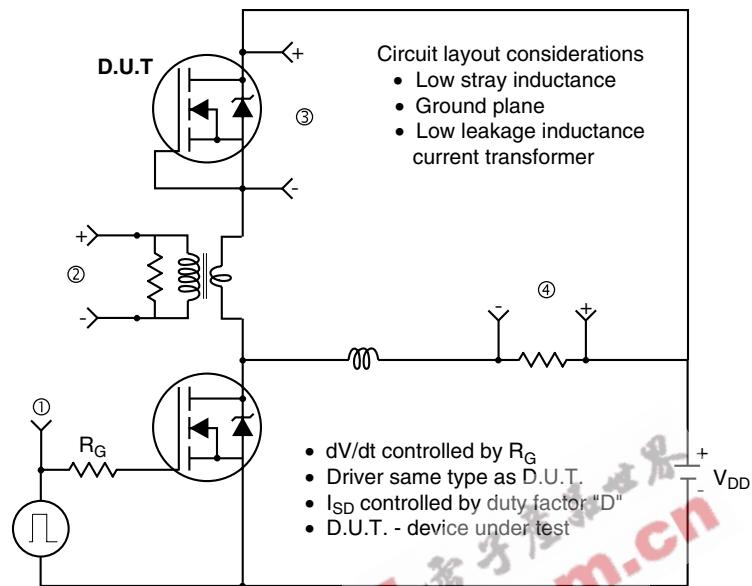


Fig. 13b - Gate Charge Test Circuit

### Peak Diode Recovery dV/dt Test Circuit



\*  $V_{GS} = 5 \text{ V}$  for logic level devices

Fig. 14 - For N-Channel

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